## **ON Semiconductor**

### Is Now



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# **SWITCHMODE™ NPN Bipolar Power Transistor**

For Switching Power Supply Applications

The BUL146G / BUL146FG have an applications specific state-of-the-art die designed for use in fluorescent electric lamp ballasts to 130 W and in Switchmode Power supplies for all types of electronic equipment.

### **Features**

- Improved Efficiency Due to Low Base Drive Requirements:
  - ♦ High and Flat DC Current Gain
  - Fast Switching
  - No Coil Required in Base Circuit for Turn-Off (No Current Tail)
- Full Characterization at 125°C
- Two Packages Choices: Standard TO-220 or Isolated TO-220
- Parametric Distributions are Tight and Consistent Lot-to-Lot
- BUL146F, Case 221D, is UL Recognized to 3500 V<sub>RMS</sub>: File # E69369
- These Devices are Pb-Free and are RoHS Compliant\*

#### **MAXIMUM RATINGS**

F	Rating	Symbol	Value	Unit
Collector-Emitter	V <sub>CEO</sub>	400	Vdc	
Collector-Base Br	eakdown Voltage	V <sub>CES</sub>	700	Vdc
Emitter-Base Volta	age	V <sub>EBO</sub>	9.0	Vdc
Collector Current	<ul><li>Continuous</li><li>Peak (Note 1)</li></ul>	I <sub>C</sub> I <sub>CM</sub>	6.0 15	Adc
Base Current	<ul><li>Continuous</li><li>Peak (Note 1)</li></ul>	I <sub>B</sub> I <sub>BM</sub>	4.0 8.0	Adc
RMS Isolation Volt (for 1 sec, F	V <sub>ISOL1</sub> V <sub>ISOL2</sub> V <sub>ISOL3</sub>	<b>BUL146F</b> 4500 3500 1500	<b>V</b>	
Total Device Dissip	P <sub>D</sub>	100 40 0.8 0.32	W W/°C	
Operating and Sto	rage Temperature	T <sub>J</sub> , T <sub>stg</sub>	-65 to 150	°C

### THERMAL CHARACTERISTICS

Characteristics	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case BUL146 BUL146F	$R_{ heta JC}$	1.25 3.125	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 5 Seconds	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Pulse Test: Pulse Width = 5 ms, Duty Cycle ≤ 10%.
- 2. Proper strike and creepage distance must be provided.

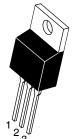


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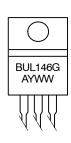
http://onsemi.com

### POWER TRANSISTOR 8.0 AMPERES **1000 VOLTS** 45 and 125 WATTS

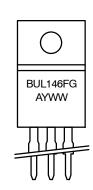
### **MARKING DIAGRAMS**



TO-220AB CASE 221A-09 STYLE 1







= Pb-Free Package = Assembly Location

= Year WW = Work Week

### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 8 of this data sheet.

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

### **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic				Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS								
Collector–Emitter Sustaining Voltage (I <sub>C</sub> = 100 mA, L = 25 mH)				V <sub>CEO(sus)</sub>	400	-	_	Vdc
Collector Cutoff Current (V <sub>CE</sub> =	Rated V <sub>CEO</sub> , I <sub>B</sub> = 0	)		I <sub>CEO</sub>	-	-	100	μAdc
Collector Cutoff Current (V <sub>CE</sub> =	Rated V <sub>CES</sub> , V <sub>EB</sub> = = 500 V, V <sub>EB</sub> = 0)	: 0)	(T <sub>C</sub> = 125°C) (T <sub>C</sub> = 125°C)	I <sub>CES</sub>	- -	_ _	100 500 100	μAdc
( 0.0	, 25 ,		(1C = 123 C)		_	_		A -1 -
Emitter Cutoff Current (V <sub>EB</sub> = 9	7.0 Vac, I <sub>C</sub> = 0)			I <sub>EBO</sub>	-	_	100	μAdc
ON CHARACTERISTICS		0.40.4	1.)		Ι			
Base-Emitter Saturation Voltag	ge ( $I_C = 1.3 \text{ Adc}, I_E$ ( $I_C = 3.0 \text{ Adc}, I_E$	,	,	V <sub>BE(sat)</sub>	-	0.82 0.93	1.1 1.25	Vdc
Collector-Emitter Saturation Vo	oltage (I <sub>C</sub> = 1.3 Ad	c, $I_B = 0.1$		V <sub>CE(sat)</sub>	-	0.22	0.5	Vdc
			$(T_C = 125^{\circ}C)$		-	0.20	0.5	
	$(I_C = 3.0 \text{ Ad})$	c, I <sub>B</sub> = 0.6	•		_	0.30	0.7	
			(T <sub>C</sub> = 125°C)		-	0.30	0.7	
DC Current Gain (I <sub>C</sub> = 0.5 Ad	c, V <sub>CE</sub> = 5.0 Vdc)			h <sub>FE</sub>	14	-	34	-
			$(T_C = 125^{\circ}C)$		-	30	-	
$(I_C = 1.3 \text{ Ad})$	c, V <sub>CE</sub> = 1.0 Vdc)				12	20	_	
			$(T_C = 125^{\circ}C)$		12	20	-	
$(I_{\rm C} = 3.0 \text{ Ad})$	c, V <sub>CE</sub> = 1.0 Vdc)		(T. 10500)		8.0	13	_	
$(T_C = 125^{\circ}C)$					7.0	12	_	
(I <sub>C</sub> = 10 mA	$dc$ , $V_{CE} = 5.0 \text{ Vdc}$				10	20	-	
DYNAMIC CHARACTERISTICS								
Current Gain Bandwidth ( $I_C = 0$	0.5 Adc, $V_{CE} = 10 \text{ V}_{CE}$	dc, f = 1.0	MHz)	f <sub>T</sub>	-	14	_	MHz
Output Capacitance (V <sub>CB</sub> = 10	Vdc, $I_E = 0$ , $f = 1.0$	MHz)		C <sub>OB</sub>	-	95	150	pF
Input Capacitance (V <sub>EB</sub> = 8.0 V)				C <sub>IB</sub>	-	1000	1500	pF
		10			-	2.5	-	
Dynamic Saturation Voltage: Determined 1.0 μs and 3.0 μs respectively after rising I <sub>B1</sub> reaches 90% of final I <sub>B1</sub> (see Figure 18)	$(I_C = 1.3 \text{ Adc})$ $I_{B1} = 300 \text{ mAdc}$ $V_{CC} = 300 \text{ V})$	1.0 µs	(T <sub>C</sub> = 125°C)		-	6.5	-	
		3.0 μs (T	(T <sub>C</sub> = 125°C)		-	0.6	_	
				V <sub>CE(dsat)</sub>	_	2.5	-	V
	% of	1.0 μs	/T- 105°C\	▼ CE(asat)	-	3.0	-	•
			(T <sub>C</sub> = 125°C)	4		7.0	_	
		(T <sub>C</sub> = 125°C)		-	0.75 1.4	-		

	Characteristic		Symbol	Min	Тур	Max	Unit
SWITCHING CHARACT	TERISTICS: Resistive Load (D.C. ≤	10%, Pulse Width	= 20 μs)				
Turn-On Time	(I <sub>C</sub> = 1.3 Adc, I <sub>B1</sub> = 0.13 Adc I <sub>B2</sub> = 0.65 Adc, V <sub>CC</sub> = 300 V)	(T <sub>C</sub> = 125°C)	t <sub>on</sub>	_ _	100 90	200 -	ns
Turn-Off Time		(T <sub>C</sub> = 125°C)	t <sub>off</sub>	- -	1.35 1.90	2.5 -	μs
Turn-On Time	(I <sub>C</sub> = 3.0 Adc, I <sub>B1</sub> = 0.6 Adc I <sub>B1</sub> = 1.5 Adc, V <sub>CC</sub> = 300 V)	(T <sub>C</sub> = 125°C)	t <sub>on</sub>	- -	90 100	150 -	ns
Turn-Off Time		(T <sub>C</sub> = 125°C)	t <sub>off</sub>	- -	1.7 2.1	2.5 -	μs
SWITCHING CHARACT	TERISTICS: Inductive Load (V <sub>clamp</sub>	= 300 V, V <sub>CC</sub> = 15	V, L = 200 μH)				
Fall Time	(I <sub>C</sub> = 1.3 Adc, I <sub>B1</sub> = 0.13 Adc I <sub>B2</sub> = 0.65 Adc)	(T <sub>C</sub> = 125°C)	t <sub>fi</sub>	_ _	115 120	200 -	ns
Storage Time		(T <sub>C</sub> = 125°C)	t <sub>si</sub>	- -	1.35 1.75	2.5 -	μs
Crossover Time		(T <sub>C</sub> = 125°C)	t <sub>c</sub>	- -	200 210	350 -	ns
Fall Time	(I <sub>C</sub> = 3.0 Adc, I <sub>B1</sub> = 0.6 Adc I <sub>B2</sub> = 1.5 Adc)	(T <sub>C</sub> = 125°C)	t <sub>fi</sub>	- -	85 100	150 -	ns
Storage Time		(T <sub>C</sub> = 125°C)	t <sub>si</sub>	-	1.75 2.25	2.5 -	μs
Crossover Time		(T <sub>C</sub> = 125°C)	t <sub>c</sub>	- -	175 200	300	ns
Fall Time	$(I_C = 3.0 \text{ Adc}, I_{B1} = 0.6 \text{ Adc} $ $I_{B2} = 0.6 \text{ Adc})$	(T <sub>C</sub> = 125°C)	t <sub>fi</sub>	80 -	_ 210	180 -	ns
Storage Time		(T <sub>C</sub> = 125°C)	t <sub>si</sub>	2.6 -	- 4.5	3.8	μs
Crossover Time		(T <sub>C</sub> = 125°C)	t <sub>c</sub>	- -	230 400	350 -	ns

### TYPICAL STATIC CHARACTERISTICS

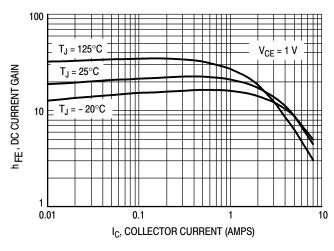


Figure 1. DC Current Gain @ 1 Volt

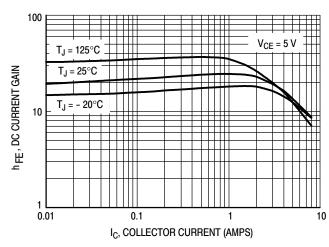


Figure 2. DC Current Gain @ 5 Volts

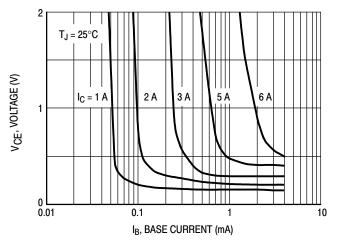


Figure 3. Collector Saturation Region

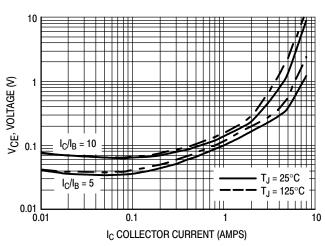


Figure 4. Collector-Emitter Saturation Voltage

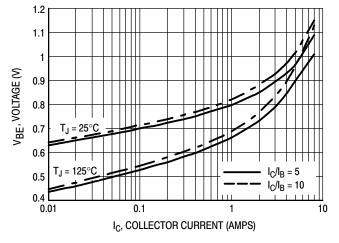


Figure 5. Base-Emitter Saturation Region

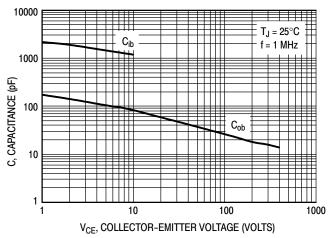
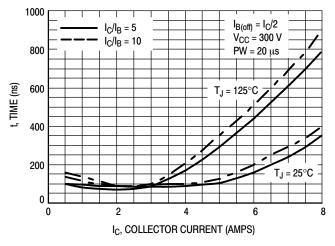


Figure 6. Capacitance

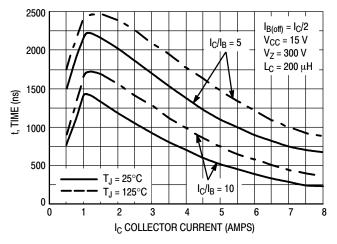
# TYPICAL SWITCHING CHARACTERISTICS $(I_{B2} = I_C/2 \text{ for all switching})$



4000  $I_{B(off)} = I_{C}/2$  $T_J = 25^{\circ}C$  $V_{CC} = 300 \text{ V}$ 3500 T<sub>J</sub> = 125°C  $PW = 20 \mu s$  $I_C/I_B = 5$ 3000 2500 t, TIME (ns)  $I_C/I_B = 10$ 2000 1500 1000 500 IC, COLLECTOR CURRENT (AMPS)

Figure 7. Resistive Switching, ton

Figure 8. Resistive Switching, toff



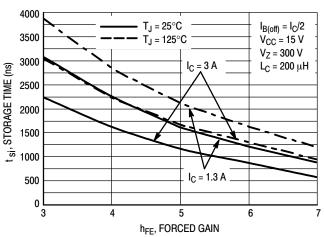
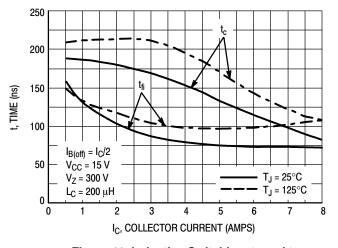


Figure 9. Inductive Storage Time, tsi

Figure 10. Inductive Storage Time, t<sub>si</sub>(h<sub>FE</sub>)



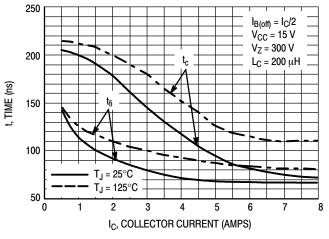
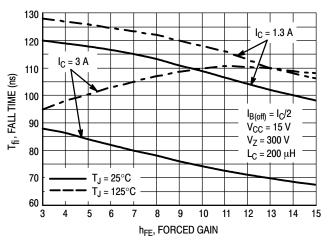


Figure 11. Inductive Switching,  $t_c$  and  $t_{fi}$   $I_C/I_B=5$ 

Figure 12. Inductive Switching,  $t_c$  and  $t_{fi}$   $I_C/I_B = 10$ 

# TYPICAL SWITCHING CHARACTERISTICS $(I_{B2} = I_C/2 \text{ for all switching})$

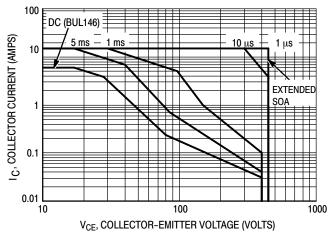


250 T<sub>C</sub>, CROSS-OVER TIME (ns) 200 150  $I_C = 3 A$  $I_{B(off)} = I_{C}/2$ V<sub>CC</sub> = 15 V  $T_J = 25^{\circ}C$ V<sub>Z</sub> = 300 V T<sub>J</sub> = 125°C L<sub>C</sub> = 200 μH 50 5 6 7 10 11 12 13 h<sub>FF</sub>, FORCED GAIN

Figure 13. Inductive Fall Time

Figure 14. Inductive Cross-Over Time

### **GUARANTEED SAFE OPERATING AREA INFORMATION**



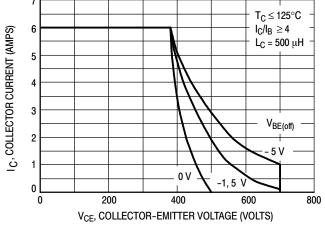


Figure 15. Forward Bias Safe Operating Area

Figure 16. Reverse Bias Switching Safe Operating Area

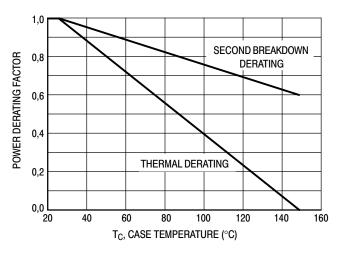
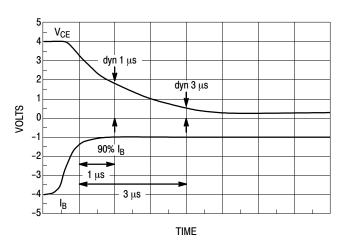


Figure 17. Forward Bias Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I<sub>C</sub> - V<sub>CE</sub> limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 15 is based on  $T_C = 25^{\circ}C$ ;  $T_{J(pk)}$  is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when  $T_C > 25$ °C. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown in Figure 15 may be found at any case temperature by using the appropriate curve on Figure 17. T<sub>J(pk)</sub> may be calculated from the data in Figure 20. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base-to-emitter junction reverse-biased. The safe level is specified as a reversebiased safe operating area (Figure 16). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.



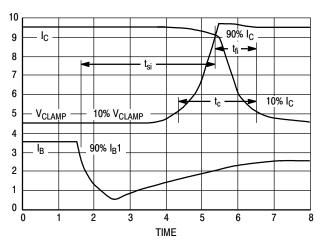
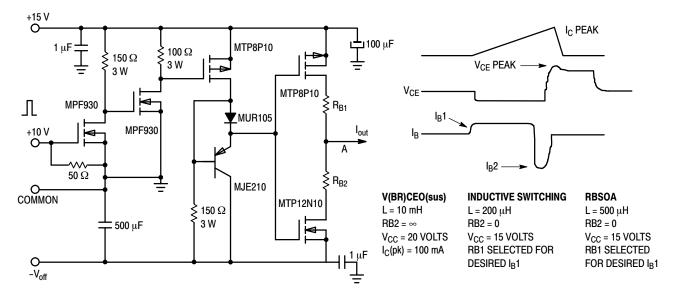


Figure 18. Dynamic Saturation Voltage Measurements

Figure 19. Inductive Switching Measurements



**Table 1. Inductive Load Switching Drive Circuit** 

### **TYPICAL THERMAL RESPONSE**

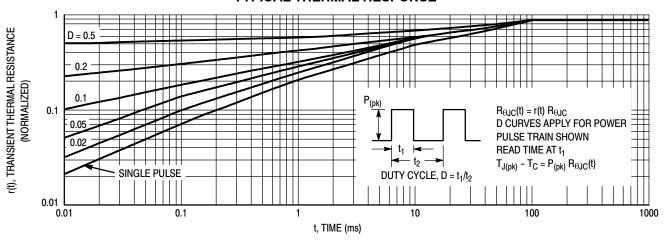


Figure 20. Typical Thermal Response ( $Z_{\theta JC}(t)$ ) for BUL146

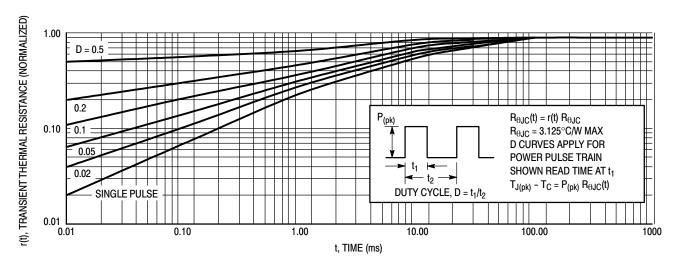


Figure 21. Typical Thermal Response for BUL146F

### **ORDERING INFORMATION**

Device	Package	Shipping
BUL146G	TO-220AB (Pb-Free)	50 Units / Rail
BUL146FG	TO-220 (Fullpack) (Pb-Free)	50 Units / Rail

### **TEST CONDITIONS FOR ISOLATION TESTS\***

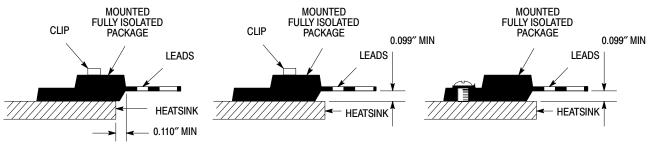


Figure 22a. Screw or Clip Mounting Position for Isolation Test Number 1

Figure 22b. Clip Mounting Position for Isolation Test Number 2

Figure 22c. Screw Mounting Position for Isolation Test Number 3

\*Measurement made between leads and heatsink with all leads shorted together

#### **MOUNTING INFORMATION\*\***

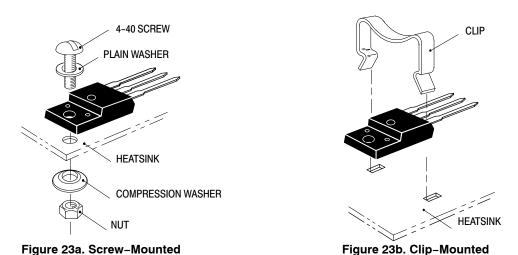


Figure 23. Typical Mounting Techniques for Isolated Package

Laboratory tests on a limited number of samples indicate, when using the screw and compression washer mounting technique, a screw torque of 6 to 8 in · lbs is sufficient to provide maximum power dissipation capability. The compression washer helps to maintain a constant pressure on the package over time and during large temperature excursions.

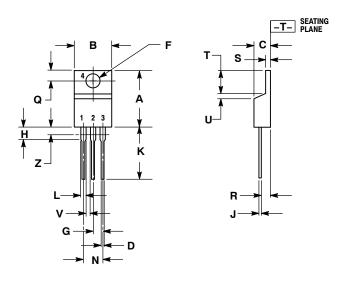
Destructive laboratory tests show that using a hex head 4–40 screw, without washers, and applying a torque in excess of 20 in · lbs will cause the plastic to crack around the mounting hole, resulting in a loss of isolation capability.

Additional tests on slotted 4–40 screws indicate that the screw slot fails between 15 to 20 in · lbs without adversely affecting the package. However, in order to positively ensure the package integrity of the fully isolated device, ON Semiconductor does not recommend exceeding 10 in · lbs of mounting torque under any mounting conditions.

<sup>\*\*</sup> For more information about mounting power semiconductors see Application Note AN1040.

### **PACKAGE DIMENSIONS**

### TO-220AB CASE 221A-09 **ISSUE AF**



#### NOTES:

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

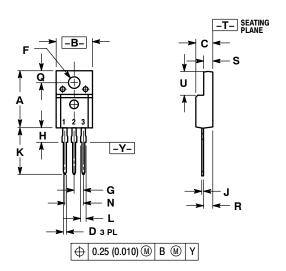
  2. CONTROLLING DIMENSION: INCH.

  3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.161	3.61	4.09
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.014	0.025	0.36	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
7		0.080		2 04

- STYLE 1:
  PIN 1. BASE
  2. COLLECTOR
  - EMITTER
  - COLLECTOR

### TO-220 FULLPAK CASE 221D-03 ISSUE G



### NOTES:

- VOIES: Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH 3. 2210-01 THRU 2210-02 OBSOLETE, NEW STANDARD 221D-03.

	INC	HES	MILLIMETERS			
DIM	MIN	MAX	MIN	MAX		
Α	0.625	0.635	15.88	16.12		
В	0.408	0.418	10.37	10.63		
С	0.180	0.190	4.57	4.83		
D	0.026	0.031	0.65	0.78		
F	0.116	0.119	2.95	3.02		
G	0.100	BSC	2.54 BSC			
Н	0.125	0.135	3.18	3.43		
J	0.018	0.025	0.45	0.63		
K	0.530	0.540	13.47	13.73		
L	0.048	0.053	1.23	1.36		
N	0.200	BSC	5.08 BSC			
Q	0.124	0.128	3.15	3.25		
R	0.099	0.103	2.51	2.62		
S	0.101	0.113	2.57	2.87		
U	0.238	0.258	6.06	6.56		

STYLE 2: PIN 1. BASE

- 2. COLLECTOR 3. EMITTER

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